## Notice of References Cited Application/Control No. 10/501,892 Examiner Qiuwen Mi Applicant(s)/Patent Under Reexamination HIRAMOTO ET AL. Art Unit Page 1 of 1 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,329,002	12-2001	Kim et al.	426/71
*	В	US-4,013,800	03-1977	Shimazaki et al.	426/536
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	UŞ-			
	Н	US-			
	ı	US-	-		
	J	US-			
	к	US-			
	L	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## NON-PATENT DOCUMENTS

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